Neutron diffraction, electronic band structure and electrical resistivity of Mo_{3-x}Ru_xSb₇

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Abstract

Neutron diffraction experiments, KKR-CPA electronic band structure calculations as well as electrical resistivity measurements have been performed on polycrystalline Mo₃₋ $_x$ Ru_xSb₇ samples for $0 \le x \le 1$. Neutron diffraction studies have been undertaken at room temperature and extended down to 4 K to get a better understanding of the crystalline structure modifications as the Ru content increases. Both structural and chemical characterizations have unambiguously revealed a solubility limit of the Ru atoms close to 0.8. Electronic band structure calculations have provided theoretical evidence of a progressive transition from a metalliclike state (x = 0) towards a semiconducting-like character as x = 1 is approached, although the solubility limit of Ru precludes a crossover to a semiconducting behaviour. The theoretical prediction has been experimentally confirmed by low temperature electrical resistivity measurements from 2 up to 350 K.

Introduction

An efficient thermoelectric material requires a high value of the dimensionless figure of merit at a temperature *T*, *ZT*, defined as $ZT = \alpha^2 T / \rho \lambda$ where α stands for the Seebeck coefficient or thermopower, ρ the electrical resistivity and λ the total thermal conductivity.^{1,2} If the overall improvement in the figure of merit has been marginal for more than forty years (1950-1990), the situation has radically changed in the early 90's. Twenty years ago, a resurgence of interest in thermoelectricity occured due to new theoretical guidelines predicting that nanostructured compounds as well as open crystalline structures could exhibit enhanced thermoelectric performance.³⁻⁵ If the former idea is primarily based on quantum-confinement phenomena leading to variations of the density of states at the Fermi

level favourable to achieve high thermopower values, the latter is related to the presence of cages in the crystalline structure where loose bonded atoms can be inserted. These atoms can rattle about their equilibrium positions giving rise to a resonant scattering mechanism and thus to a marked lowering of the lattice thermal conductivity. Following these theoretical guidelines, huge experimental efforts have then been devoted to demonstrate the proof-of-principle. Exciting discoveries in low-dimensional structures such as quantum wells or quantum wires have been reported with the achievement of *ZT* values close to 2-3 near room temperature.⁶⁻¹³ Encouraging results have also been obtained in cage compounds such as clathrates and skutterudites where *ZT* values exceeding unity have been discovered in the 500 – 800 K temperature range.¹⁴⁻¹⁶

Another interesting field of investigation to discover high-efficiency thermoelectric materials is linked to the research of complex crystalline structure displaying a large number of atoms per unit cell. Among the different classes of compounds investigated up-to-now, Zintl phases have attracted great attention in the last five years from a thermoelectric point of view.¹⁷ *ZT* values greater than unity have been obtained in the Yb₁₄MnSb₁₁ and Yb₁₄Mn₁. _xZn_xSb₁₁ compounds at high temperature, near 1200 K, demonstrating their potential for high temperature power generation.^{18,19}

Another prospective family of Zintl phases, namely M_3T_7 (with M = Nb, Mo, Tc, Re, Ru, Os, Ir, Co, Ni, Pd and Pt and T = Sb, Te, As, Sn, Si, Al, Ga, Ge, In, Pb and Tl) crystallizing in the cubic Ir₃Ge₇ structure type (space group *Im3m*, No. 229, 40 atoms per unit cell) has been recently considered as prime candidates for power generation near 1000 K.²⁰⁻²² These compounds crystallize in a body centered cubic structure which is usually described as a three-dimensional arrangement of elementary building blocs formed by two antiprisms of T atoms.²¹⁻²⁴ Another useful crystallographic description can be obtained if we consider both the M and T sublattices. The M atoms form a body centered cubic sublattice composed of

octahedral structures similar to the LaB₆ crystalline structure (Figure 1).²⁵ The T1 atoms (T atoms are present on two inequivalent sites called T1 and T2) form truncated octahedra composed of six square faces and eight hexagonal faces (Figure 2a). The T2 atoms constitute dumbbell structures located perpendicularly at the center of each hexagonal face. The M and T sublattices are then assembled by positioning an M octahedral structure at the center of the T truncated octahedra (Figure 2b).

Among the different compounds which belong to this family, the Re₃As₇ and Mo₃Sb₇ compounds were found to be two interesting systems with potential for high ZT values.^{20,21,23} If only few experimental studies have been devoted to the former compound up-to-now, the latter has been more deeply studied both from a fundamental and thermoelectric point of view.²⁶⁻²⁸ Besides superconducting properties,²⁹⁻³² Mo₃Sb₇ exhibits exotic magnetic interactions leading to the opening of a spin gap in the spin excitation spectrum at $T^* = 53$ K.²⁶ One important feature in Mo₃Sb₇ and Re₃As₇ lies in the presence of an energy gap near the Fermi level offering the opportunity to reach a semiconducting state. Band structure calculations have shown that adding two electrons to Mo₃Sb₇ or one hole to Re₃As₇ should lead to a crossover to semiconducting properties.^{20,23} It should be emphasized that this scenario supposes rigid-like behaviour of the electronic structure when electrons (Mo₃Sb₇) or holes (Re₃As₇) are added. These theoretical predictions have been experimentally investigated by substituting Sb by Te and As by Ge atoms.^{20,23} One of the essential features of the former study is the existence of a solubility limit of Te which prevents the Fermi level from being driven into the gap. Nevertheless, as suggested by band structure calculations, these substitutions give rise to a shift of the Fermi level towards the valence and conduction band edges, respectively. Thus, both promising p-type and n-type materials, namely Mo₃Sb_{7-x}Te_x and Re₃As_{7-x}Ge_x, respectively, were found to present good thermoelectric properties at high temperature.^{21,23} These ZT improvements are mainly related to the Ge and Te concentration increases which are accompanied by an enhancement of the Seebeck coefficient. Therefore, it is of prime interest to further investigate these systems to determine whether or not other substitutions that lead to a rigidlike behaviour of the electronic structure are possible.

In this paper, we focus our attention on the Mo_3Sb_7 compound and demonstrate that Mo can be substituted by Ru. The variation of both the crystallographic and electronic structures with the Ru content constitutes the outstanding issues we address in the present paper. To study the former property, we carried out powder neutron diffraction experiments throughout the 4 – 300 K temperature range. Band structure calculations were performed to investigate how the density of states at the Fermi level evolves with x i.e. whether or not the variation of the electronic structure can be understood within a rigid band model. To provide further experimental evidence of a progressive metal-insulator transition as the Ru content increases predicted by our KKR-CPA calculations, low temperature electrical resistivity measurements were also carried out.

II. Experimental and computational details

Synthesis. Compounds of nominal composition $Mo_{3-x}Ru_xSb_7$ with x = 0, 0.25, 0.5 and 1 were prepared from stoichiometric amounts of pure Sb powders (5NPlus, 99.999%), Mo powders (Cerac, 99.999%) and Ru powders (Alfa Aesar, 99.99%). The reaction took place under a He/H₂ (95/5 %) atmosphere in sealed evacuated quartz ampoule. The tubes were then tranferred into a programmable furnace heated up to 750°C for 10 days and then quenched in cold water. The resulting ingots were ground in an agate mortar into fine powders (< 100 µm) and further compacted into pellets in a steel die. To ensure good homogeneity of the samples, these pellets were annealed in a quartz ampoule under a He/H₂ atmosphere at 750°C for 7 days. The final products were powdered again and densified by hot pressing in a graphite die

in an argon atmosphere at 600°C for 2h under 51 MPa. The relative densities, defined as the ratio of the measured density (estimated from the geometrical dimensions and the weight of the cylindrical ingots) to the theoretical density, are 93, 98, 99 and 88% for the samples with nominal x = 0, 0.25, 0.5 and 1, respectively.

Crystalline Structure and Chemical Analysis. X-ray powder diffraction (XRD) was performed on the ground materials obtained before the sintering process. Experiments were conducted with a Siemens D500 diffractometer using CoK α radiation and equipped with a curved primary beam monochromator and a linear positive sensitive detector (PSD). X-ray diffraction patterns were recorded in the θ -2 θ mode between $20^\circ \le 2\theta \le 110^\circ$ with a 2 θ step of 0.032° and a total counting time of 3h. To obtain accurate lattice parameters, high-purity silicon ($a_0 = 5.4309$ Å) was added as an internal standard.

No secondary phases could be detected in the $Mo_{2.75}Ru_{0.25}Sb_7$ and $Mo_{2.5}Ru_{0.5}Sb_7$ compounds, but a small concentration of $RuTe_2$ (~ 5% wt.) was evident in the XRD pattern of Mo_2RuSb_7 (nominal x = 1). These results not only demonstrate that molybdenum can be successfully substituted by ruthenium but also strongly suggests a solubility limit of Ru in the Mo_3Sb_7 crystalline structure. As we have already mentioned, similar behaviour has been observed in the $Mo_3Sb_{7-x}Te_x$ system. A solubility limit of Te close to x = 1.6 was experimentally demonstrated whereas a concentration as high as x = 2 should be required to achieve semiconducting properties.^{20,21} To determine the actual chemical composition of $Mo_{2.75}Ru_{0.25}Sb_7$, $Mo_{2.5}Ru_{0.5}Sb_7$ and Mo_2RuSb_7 , electron probe microanalysis studies (EPMA) have been performed with a CAMECA SX100.

These experiments have confirmed the XRD analyses as they revealed that both the Mo_{2.75}Ru_{0.25}Sb₇ and Mo_{2.5}Ru_{0.5}Sb₇ compounds exhibit an excellent chemical homogeneity with a very good correlation between the actual and nominal compositions. This study has also corroborated the presence of secondary phases (mainly RuTe₂) in the sample of nominal

composition Mo₂RuSb₇ and has revealed a solubility limit of the Ru atoms close to 0.8. Subsequently, we synthesized a phase pure sample of Mo_{2.2}Ru_{0.8}Sb₇ at the Ru-rich limit for further experiments. Note that, for sake of clarity and to distinguish the pure sample at the solubility limit with x = 0.8 and the impure sample with nominal x = 1 samples from each other, the nominal compositions will always be used in the present paper.

The lattice parameters, a, of the different materials studied are summarized in Table 1. These results show a strong decrease of the lattice parameter, a, with the Ru content following Vegard's law (Figure 3). As we can appreciate, the lattice parameter of Mo_{2.2}Ru_{0.8}Sb₇ is slightly higher than that derived for Mo₂RuSb₇ (Table 1). We believe that this difference is linked to the experimental error of EPMA since a solubility limit of 0.85 instead of 0.8 would be in excellent agreement with Vegard's law (Figure 3).

Neutron diffraction. To study in detail the evolution of the crystalline structure with the Ru content, we have carried out powder neutron diffraction measurements on the phase pure samples. Data were collected on 3g of Mo_{2.75}Ru_{0.25}Sb₇ and Mo_{2.2}Ru_{0.8}Sb₇ powders, contained in cylindrical vanadium cans, on the time-of-flight diffractometer POLARIS at the ISIS facility, Rutherford Appleton Laboratory, U.K. ³He tube detector banks at 35°, 145° and the ZnS scintillation detector bank at 90° were used. This allows us to access an overall dspacing spanning the range $0.3 \le d \le 8$ Å. Data were acquired at room temperature for the Mo_{2.75}Ru_{0.25}Sb₇ and Mo_{2.2}Ru_{0.8}Sb₇ compounds as well as at low temperature (220, 150, 80 and 4 K) for the latter. To compare the crystallographic data of the Ru substituted samples with those of the parent compound, additional experiments at the same temperatures have been performed on Mo₃Sb₇. All these measurements were acquired for 2 h at all temperatures and made for an integrated proton current at the production target of 200µA.h. Rietveld refinements were carried out on the data collected on the 145° bank (backscattering detectors) using the Fullprof program.³³ The relevant crystallographic details from the neutron diffraction analysis are summarized in Table 2.

Electronic Band Structure Calculations. Electronic structure calculations of the $Mo_{3-x}Ru_xSb_7$ system ($0 \le x \le 1$) were performed by the Korringa-Kohn-Rostoker³⁴⁻³⁶ method with the coherent potential approximation, where the chemical disorder has been treated as a random atom distribution on the Mo site. The self-consistent crystal potential of the muffin-tin form was constructed within the local density approximation (LDA) applying the Perdew-Wang formula for the exchange-correlation part. For well-converged charges and potentials, total and partial densities of states were computed. Experimental lattice constants and positional parameters of Mo (12e) and Sb2 (16f) atoms derived from our neutron diffraction analysis were used in these calculations.

Electrical Resistivity Measurements. Electrical resistivity measurements were carried out over the temperature range 2-350 K using an ac transport measurement system option (PPMS-Quantum Design). This study was realized on parallelepipedic shaped samples cut from the hot pressed ingots with a diamond wire saw to typical dimensions of 2x2x10 mm³. Ohmic contacts to the samples were made with fine copper wires carefully attached using a tiny amount of silver paint.

III. Results and discussion

Neutron diffraction analysis. The refinements against data on Mo₃Sb₇ were performed using the published XRD data as a starting model. This compound undergoes a structural deformation below $T^* = 53$ K where a spin gap opens in the spin excitation spectrum.^{37,38} Low temperature XRD investigations on polycrystalline sample shed light on this structural symmetry breaking by suggesting a cubic-to-tetragonal transformation (space group *I4/mmm*). Thus, the lattice parameter of the cubic structure, *a*, splits into two distinct

parameters a and c with a < c without any drastic changes in the lattice volume. The amplitude of the deformation was found to be very slight as typified by a a/c ratio close to unity $(a/c \sim 1.002 \text{ at } 10 \text{ K})$.³⁸ However, these experiments did not rule out possibilities of crystal lattice with lower symmetry nor long period modulated lattice. XRD measurements on high quality single crystal are therefore mandatory to definitively settle this issue. Such slight transformation could not be resolved in the present neutron diffraction experiments performed on a medium resolution instrument and hence, we refined the 4 K pattern by considering the cubic phase displayed by Mo₃Sb₇ above T^{*}. For each temperature investigated, the refinement easily converged to a fully ordered atom arrangement with respect to the site distribution of Mo and Sb atoms and hence, leads to good agreement factors (Table 3). The relevant crystallographic parameters are listed in Table 4. The anisotropic thermal displacement parameters as well as selected bond lengths are provided in the Supporting Information file. The lattice parameter obtained at 300 K is in very good agreement with those found in previous works.²⁴ Interestingly, the isotropic atomic displacement parameter of the Mo atoms is significantly lower than those of the Sb1 and Sb2 atoms. This behaviour is likely due to the position of the Mo atoms inside the antiprisms. From the temperature dependences of the lattice parameter and ADP values, valuable information on Mo₃Sb₇ can be inferred. As shown in Figure 4, the lattice parameter decreases linearly down to 150 K and then tends to saturate as the temperature is decreased to 4 K. The thermal dilatation coefficient α_T can be derived from the temperature dependence of the lattice parameter using

$$\alpha_T = \left(\frac{1}{V}\frac{\partial V}{\partial T}\right)_p = \left(\frac{3}{a}\frac{\partial a}{\partial T}\right)_p \tag{1}$$

At 300 K, α_T is equal to 25.10⁻⁶ K⁻¹. Both this value and the temperature evolution of the lattice parameter are similar to those observed for other thermoelectric materials such as skutterudites for instance.³⁹ Using the temperature dependence of the isotropic thermal

displacement parameters, the Debye temperature, θ_D , can be estimated using the formalism developped by Willis and Pryor⁴⁰

$$\overline{B_{iso}} = \frac{6nh^2}{Mk_B\theta_D} \left[\frac{\Phi\left(\frac{\theta_D}{T}\right)}{\frac{\theta_D}{T}} + \frac{1}{4} \right]$$
(2)

with $\Phi(x) = \frac{1}{x} \int_0^x \frac{y}{e^y - 1} dy$. In equation 2, $\overline{B_{iso}}$ stands for the mean value of the thermal displacement parameter of both Mo and Sb atoms, M the molar weight of the Mo₃Sb₇ compound, n the number of atoms per unit cell, h the Planck constant and k_B the Boltzmann constant. From the crystallographic data summarized in Table 4 and with n = 40 and $M = 1140.14 \text{ g.mol}^{-1}$, we get $\theta_D \sim 300 \text{ K}$, in very good agreement with the values derived from ultrasound velocity analysis ($\theta_D \sim 285 \text{ K}$) and low temperature specific heat measurements $(\theta_D \sim 310 \text{ K}).^{27,28}$

In the following part, we turn our attention to the variations of the crystallographic parameters as the Ru content increases.

Figure 5 illustrates the refinement of the neutron time-of-flight diffraction pattern of Mo_{2.75}Ru_{0.25}Sb₇ obtained at 300 K. The crystallographic parameters of Mo₃Sb₇ determined at 300 K were used as a starting model. Because of similar scattering lengths (Mo: 6.715 fm and Ru: 7.03 fm), atomic displacement parameters and site occupancy factors were not simultaneously refined. Thus, the Ru content has been fixed to its nominal value. This hypothesis seems reasonable considering that the sample is single phase and that EPMA measurements have suggested phase homogeneity. The model then easily converged to good agreement factors (Table 3). No ordering of the Ru atoms on the Mo site could be evidenced by neutron diffraction nor by XRD experiments suggesting that Ru atoms randomly occupy the Mo site. The key parameters of the crystalline structure are given in Table 5. The lattice

parameter is in very good agreement with that determined by x-ray diffraction. The decrease of this characteristic is, as expected, related to a decrease of the different bond lengths of the structure (Table 6). An exception to this behaviour is related to the Mo-Mo bond lengths which decrease initially and then increase for higher Ru concentration. However, it must be emphasized that this exception depends on the lattice parameter value. The value derived from x-ray diffraction experiment would lead to lower Mo-Mo bond lengths which will therefore progressively increase with the Ru content (the behaviour of all other bond lengths with x will remain unchanged).

The refinement of the structure of Mo_{2.2}Ru_{0.8}Sb₇ was performed using the crystallographic parameters of the x = 0.25 sample as the starting model and by following the same approach. It must be emphasized that the low temperature deformation that characterizes the Mo₃Sb₇ compound no longer exists in the Ru substituted samples. Convergence was rapidly attained and led to good agreement factors at all temperatures (Table 3). The crystallographic data are summarized in Table 7. The anisotropic thermal displacement parameters and selected bond lengths for each temperature investigated can be found in the Supporting Information file. The low temperature dependence of both the lattice parameter and ADP values allows us to determine the thermal dilatation coefficient and the Debye temperature, respectively (Figure 4). Using equations (1) and (2), we get $\alpha_T \sim 23.10^{-6}$ K⁻¹ and $\theta_p \sim 320$ K. As expected, these values are very close to those obtained for the parent compound since Mo and Ru atoms display close molar mass and atomic radius.

Soheilnia et al.⁴¹ have suggested that lowering the lattice thermal conductivity could be possible in Mo₃Sb₇ by insertion of small cations into the cubic voids of the crystalline structure formed by the Sb2 atoms. It is interesting to underline that the presence of ruthenium leads to a decrease of the Sb2-Sb2 bonds and as a consequence, to a decrease of the size of the cubes. Hence, if such insertions are possible in Mo₃Sb₇, this structural characteristic seems to

strongly restrict this field of investigation to optimize the thermolectric properties of these Ru substituted compounds.

The insertion of Ru atoms in the Mo₃Sb₇ crystalline structure should lead to a shift of the Fermi level toward the valence band edge since this substitution is expected to bring two additional electrons per Ru atom. This picture implies 'rigid' behaviour of the electronic structure as the Ru content increases. To glean what happens to the band structure when the Ru fraction spans the range $0 \le x \le 1$, we have undertaken electronic band structure calculations.

Electronic Structure Calculations. Figure 6 illustrates the total density of states at the Fermi level, $N(E_F)$, as a function of the Ru content. As this figure shows, the increase of the ruthenium content dramatically alters $N(E_F)$ which decreases with x. For x = 1, two electrons are added and all contributions vanish: the Fermi level enters the gap and a crossover from the metallic state to a semiconducting regime occurs. In addition, this evolution supports the idea of a rather 'rigid' behaviour of the valence bands. Further evidence for this viewpoint is delivered by the variations of $N(E_F)$ as a function of the energy, displayed for several Ru contents in Figure 7. Besides the shift of the Fermi level, these data highlight the slight modifications undergone by the valence bands as x increases.

Even though our experimental data have revealed a solubility limit of Ru lower than the required value to change the nature of the conduction process, the increase of the Ru content should lead to a decrease of $N(E_F)$ and, as a consequence, a decrease of the carrier concentration should arise. This picture can be experimentally investigated by measuring the electrical resistivity of the Mo_{2.75}Ru_{0.25}Sb₇, Mo_{2.5}Ru_{0.5}Sb₇ and Mo₂RuSb₇ compounds.

Electrical Resistivity Measurements. Figure 8 shows the temperature dependence of the electrical resistivity in the 2 – 350 K temperature range. The x = 0, 0.25 and 0.5 samples display metal-like character (positive $d\rho/dT$) in the whole temperature range whereas the x

= 1 sample shows similar behaviour only above 15 K. These results unequivocally show that the Ru concentration is too low to achieve a changeover to semiconducting behaviour. As can be clearly noticed, the electrical resitivity values increase with the Ru fraction. The strong difference between the x = (0, 0.25, 0.5) and x = 1 samples is only partially related to the lower relative density of the latter. Actually, as evidenced by our KKR-CPA outcomes displayed in Figure 6, the decrease of $N(E_F)$ is more pronounced for x > 0.5. Thus, we can expect a more dramatic decrease of the carrier concentration leading to a higher drop in the electrical resistivity values. These results strongly corroborate our theoretical statements: the variation of the electrical resistivity mainly depends on the carrier density which is controlled by the position of the Fermi level. Actually, magnetotransport measurements performed on these compounds, and described in detail elsewhere,⁴² show that the Hall carrier mobility, μ_{H} , does not exhibit strong variations with the Ru content (μ_H is of the order of a few cm².V⁻¹.s⁻ ¹). Thus, the electrical resistivity increase is intimately related to the decrease of the carrier density which, in turn, is related to the decrease of N(E_F). Therefore, even though a semiconducting state is not reached, these measurements provide strong evidence of a progressive metal-insulator transition as the Ru content increases.

Conclusion

In this paper, we have discussed the evolution of both the crystalline and electronic structure of polycrystalline $Mo_{3-x}Ru_xSb_7$ compounds as the Ru content increases. Chemical and structural characterizations based on EPMA and XRD have revealed the existence of a solubility limit of ruthenium in Mo_3Sb_7 which we have determined to correspond to $x \sim 0.8$. Neutron diffraction experiments down to 4 K shed some light on the essential feature of the crystal structure i.e. a strong decrease of the lattice parameter when x spans the range $0 \le x \le 0.8$.

1. Band structure calculations have shown that an increase of the Ru fraction is associated to a decrease of the total density of states at the Fermi level up to x = 1. At this concentration, a metal-insulator transition is expected. The main result of our calculations lies in the rigidlike behaviour of the electronic structure by adding electrons. Such variation is coherent with an enhancement of the electrical resistivity when x increases. These measurements also clearly demonstrate that a changeover to semiconducting properties does not occur due to the solubility limit of ruthenium. Low temperature transport property measurements will provide a deeper insight into the microscopic mechanisms which govern the electrical and thermal conduction processes while high temperature experiments will help to assess properly the thermoelectric potential of these new compounds.

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Supporting Information Available: Four tables of the temperature dependence of the anisotropic thermal displacement parameters and selected bond lengths of Mo₃Sb₇ and Mo_{2.2}Ru_{0.8}Sb₇.

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Table 1. Lattice parameter of the $Mo_{3-x}Ru_xSb_7$ compounds for x = 0, 0.25, 0.5 and 1 as determined from x-ray diffraction.

Chemical Formula	Lattice Parameter (Å)
Mo ₃ Sb ₇	9.568(8)
Mo _{2.75} Ru _{0.25} Sb ₇	9.550(4)
$Mo_{2.5}Ru_{0.5}Sb_7$	9.524(9)
$Mo_{2.2}Ru_{0.8}Sb_7$	9.504(9)
Mo_2RuSb_7	9.500(8)

Table 2. Crystallographic data from neutron diffraction experiments on the Mo₃Sb₇ and Mo_{3-x}Ru_xSb₇ compounds (x = 0.25 and 0.8).

	Mo ₃ Sb ₇	Mo _{2.75} Ru _{0.25} Sb ₇	$Mo_{2.2}Ru_{0.8}Sb_7$
fw (g.mol ⁻¹)	1140.1	1141.4	1144.2
T (K)	298	298	298
space group	Im3m	Im3m	Im3m
cell dimensions a (Å)	9.5715	9.5483	9.5073
V (Å ³)	876.90	870.52	859.36
no. of formula units per cell	4	4	4
calcd density (g.cm ⁻³)	8.64	8.71	8.85
TOF range (µs)	2000-19000	2000-19000	2000-19000

Table 3. Agreement factors of the Rietveld analysis of the $Mo_{3-x}Ru_xSb_7$ neutron diffraction patterns for x = 0, 0.25 and 0.8.

Sample	x = 0			x = 0.25 x = 0.8							
	300 K	220 K	150 K	80 K	4 K	300 K	300 K	220 K	150 K	80 K	4 K
R _p	1.22	1.28	1.40	1.43	1.46	3.01	1.55	1.62	1.65	1.72	1.71
R_{wp}	0.92	1.00	1.07	1.13	1.16	2.86	1.14	1.17	1.23	1.23	1.27
Rexp	0.70	0.70	0.71	0.71	0.71	1.24	0.83	0.83	0.83	0.83	0.83
χ^2	1.70	2.00	2.29	2.57	2.65	5.34	1.88	1.98	2.20	2.18	2.31

atom	site	x	У	Ζ	$B_{iso}(Å^2)$	occupancy (%)
			300 K			
Mo	12e	0.343(5)	0	0	0.31(2)	100
Sb1	12d	0.25	0	0.5	0.44(7)	100
Sb2	16f	0.162(3)	0.162(3)	0.162(3)	0.45(6)	100
			220 K			
Mo	12e	0.343(5)	0	0	0.24(8)	100
Sb1	12d	0.25	0	0.5	0.34(7)	100
Sb2	16f	0.162(4)	0.162(4)	0.162(4)	0.35(2)	100
			150 K			
Мо	12e	0.343(4)	0	0	0.20(2)	100
Sb1	12d	0.25	0	0.5	0.26(5)	100
Sb2	16f	0.162(3)	0.162(3)	0.162(3)	0.25(9)	100
			80 K			
Mo	12e	0.342(6)	0	0	0.16(6)	100
Sb1	12d	0.25	0	0.5	0.18(9)	100
Sb2	16f	0.161(6)	0.161(6)	0.161(6)	0.17(3)	100
			4 K			
Мо	12e	0.343(2)	0	0	0.15(1)	100
Sb1	12d	0.25	0	0.5	0.15(2)	100
Sb2	16f	0.162(2)	0.162(2)	0.162(2)	0.11(9)	100

Table 4. Atomic positions and isotropic displacement parameters (given in Å²) of Mo₃Sb₇.

Table 5. Relevant crystallographic parameters of the Mo_{2.75}Ru_{0.25}Sb₇ compound.

atom	site	x	У	Z	$B_{iso}(\text{\AA}^2)$	occupancy (%)
Mo	12e	0.343(3)	0	0	0.26(2)	91.7
Ru	12e	0.343(3)	0	0	0.26(2)	8.3
Sb1	12d	0.25	0	0.5	0.44(6)	100
Sb2	16f	0.162(4)	0.162(4)	0.162(4)	0.45(1)	100

Table 6. Selected interatomic distances (Å) of Mo_3Sb_7 , $Mo_{2.75}Ru_{0.25}Sb_7$ and $Mo_{2.2}Ru_{0.8}Sb_7$ at

300 K.

	Mo ₃ Sb ₇	$Mo_{2.75}Ru_{0.25}Sb_7$	$Mo_{2.2}Ru_{0.8}Sb_7$
Mo-Mo	2.995(1) x1	2.991(4) x1	2.998(2) x1
Mo-Sb1	2.822(9) x4	2.816(9) x4	2.810(1) x4
Mo-Sb2	2.799(7) x4	2.792(1) x4	2.775(8) x4
Sb2-Sb2	2.907(5) x1	2.895(5) x1	2.871(2) x1
Sb2-Sb2	3.107(1) x3	3.102(4) x3	3.096(1) x3
Sb1-Sb1	3.384(0) x4	3.375(8) x4	3.361(3) x4
Sb1-Sb2	3.683(1) x8	3.673(2) x8	3.655(1) x8

atom	site	x	у	Z	$B_{iso}(\text{\AA}^2)$	occupancy (%)	
			300 K				
Mo-Ru	12e	0.342(3)	0	0	0.27(3)	73.34 / 26.66	
Sb1	12d	0.25	0	0.5	0.35(8)	100	
Sb2	16f	0.162(8)	0.162(8)	0.162(8)	0.36(2)	100	
			220 K				
Mo-Ru	12e	0.342(3)	0	0	0.20(4)	73.34 / 26.66	
Sb1	12d	0.25	0	0.5	0.26(8)	100	
Sb2	16f	0.162(8)	0.162(8)	0.162(8)	0.27(2)	100	
			150 K				
Mo-Ru	12e	0.342(3)	0	0	0.15(6)	73.34 / 26.66	
Sb1	12d	0.25	0	0.5	0.19(6)	100	
Sb2	16f	0.162(8)	0.162(8)	0.162(8)	0.18(8)	100	
			80 K				
Mo-Ru	12e	0.342(1)	0	0	0.12(6)	73.34 / 26.66	
Sb1	12d	0.25	0	0.5	0.12(7)	100	
Sb2	16f	0.162(7)	0.162(7)	0.162(7)	0.12(2)	100	
4 K							
Mo-Ru	12e	0.342(1)	0	0	0.11(3)	73.34 / 26.66	
Sb1	12d	0.25	0	0.5	0.09(6)	100	
Sb2	16f	0.162(7)	0.162(7)	0.162(7)	0.09(5)	100	

Table 7. Atomic positions and isotropic displacement parameters (given in $Å^2$) of Mo_{2.2}Ru_{0.8}Sb₇.

Figure Captions

Figure 1: Cubic centered M sublattice formed by octahedral structures in the M_3T_7 compounds.

Figure 2: (a) Sublattice composed of T1 (in blue) and T2 (in red) atoms. (b) The M octahedral structures sit at the center of the T1 and T2 sublattice.

Figure 3: Lattice parameter variation of the $Mo_{3-x}Ru_xSb_7$ system as a function of the actual Ru content determined from x-ray powder diffraction. The (\circ) symbols refer to the lattice parameters of the x = 0, x = 0.25, x = 0.5 and x = 0.8 samples. The (Δ) symbol stands for the lattice parameter of the impure x = 1 sample which suggests a solubility limit of Ru of ~ 0.85 assuming Vegard's law is obeyed. The solid line represents the best fit to the data.

Figure 4: Temperature dependence of the lattice parameter of Mo₃Sb₇ (○) and Mo_{2.2}Ru_{0.8}Sb₇ (□) in the 4-300 K temperature range obtained from neutron diffraction experiments.

Figure 5: Rietveld refinement of the neutron diffraction pattern of the $Mo_{2.75}Ru_{0.25}Sb_7$ compound at 300 K. The lack of data near 13000 μ s corresponds to additional peaks coming from the vanadium can and the cryostat used for these experiments.

Figure 6: Evolution of the total density of states at the Fermi level as a function of the Ru content. The partial densities of states of the Mo and Ru atoms are also illustrated.

Figure 7: Valence bands variation as a function of the Ru content in Mo_{3-x}Ru_xSb₇.

Figure 8: Temperature dependence of the electrical resistivity of the Mo_{3-x}Ru_xSb₇ compounds for x = 0 (\circ), 0.25 (\Box), 0.5 (Δ) and 1 (\checkmark).





Figure 2a



Figure 2b









Figure 6





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Neutron diffraction, band structure and electrical resistivity of Mo_{3-x}Ru_xSb₇

Substitution of Mo by Ru atoms in the Mo_3Sb_7 compound gives rise to a contraction of the crystalline structure as well as to a 'rigid-like' behaviour of the electronic band structure that can be experimentally evidenced by the variation of the electrical resistivity with the Ru content.

